# Synchronous Step-Down Controller with 50 mA Linear Regulator

The NCP1578 is a voltage mode synchronous step-down controller for high performance systems intended to be used in battery-powered systems. The NCP1578 includes a high efficiency PWM controller with adjustable output, and a 5 V/50 mA linear regulator. A pin is provided to enable or disable forced PWM mode of operation. An internal power good voltage monitor tracks the SMPS output. NCP1578 also features soft-start sequence, UVLO for linear regulator and switcher, overvoltage protection, overcurrent protection, and thermal shutdown. The IC is packaged in QFN20.

#### **Features**

- Fixed 5.0 V/50 mA Internal Linear Regulator
- Adjustable PWM Output Voltage
- 1.5% Accuracy 0.8 V Reference
- 4.5 V to 24 V Battery/Adaptor Voltage Range
- Selectable Force PWM Mode
- Lossless, Programmable High Side MOSFET's R<sub>DS(ON)</sub> Current Sensing
- Soft-start and Power-Up Sequencing
- Overvoltage Protection, Undervoltage Protection
- Programmable Delay Power Good Output
- Thermal Shutdown
- Housed in QFN20
- This is a Pb-Free Device

#### **Typical Applications**

- Network HUB, Switchers and Routers
- 3-Cell and 4-Cell Li-ion Battery-Powered Devices
- Personal Computer Peripherals
- Microprocessors Power Supply
- Embedded Controller
- DSP and Core Processor
- Supply for LCD Display



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QFN20 MN SUFFIX CASE 485E

#### **MARKING DIAGRAM**

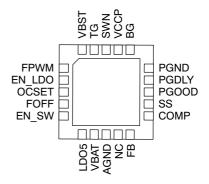
20 1 O N1578 ALYW•

N1578 = Specific Device Code A = Assembly Location

L = Wafer Lot Y = Year W = Work Week ■ Pb-Free Package

(Note: Microdot may be in either location)

#### **PIN CONNECTIONS**



#### **ORDERING INFORMATION**

Device	Package	Shipping
NCP1578MNR2G	QFN20 (Pb-Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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#### **DETAILED BLOCK DIAGRAM**

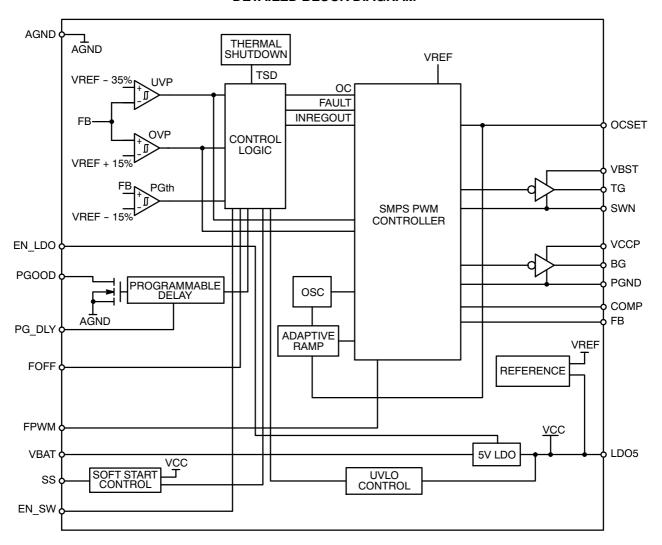


Figure 1. Detailed Block Diagram

### **TYPICAL APPLICATION CIRCUITS**

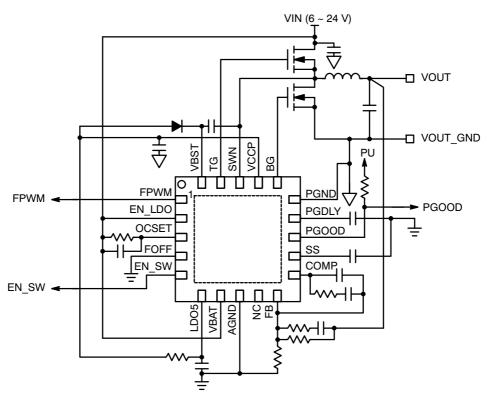


Figure 2. Single Supply VBAT Configuration

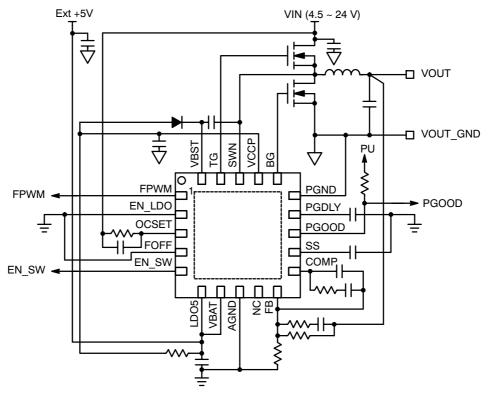


Figure 3. External 5 V and VIN Configuration

# PIN FUNCTION DESCRIPTION

Pin No.	Symbol	Description
1	FPWM	FPWM or Power Saving Control. Logic high enables force PWM. Logic low enables power saving operation.
2	EN_LDO	LDO enable input. The 5 V LDO is enabled if EN_LDO is high and disabled if it is low. This pin can sustain voltage as high as VBAT.
3	OCSET	Input pin for over current threshold setting for high side gate driver. Also it is for the internal ramp generator to implement the voltage feed forward rejection to the input voltage variation
4	FOFF	Fault OFF. If it pulls to high, it disables the features of OCP, UVLO and OVP. Normally it should be tied to ground. This pin is internally pulled down.
5	EN_SW	PWM controller's enable input. The switching controller is enabled if EN_SW is high and disabled if EN is low.
6	LDO5	5.0 V linear regulator output.
7	VBAT	Battery/adaptor voltage input.
8	AGND	Analog ground.
9	NC	Not connected
10	FB	Feedback input from controller's output voltage.
11	COMP	Error amplifier output pin.
12	SS	Soft-start (for switcher) capacitor connection to ground.
13	PGOOD	Power good signal open drain output. High impedance (open drain) if power is good (in regulation). Low impedance if power is not good.
14	PGDLY	Power good delay capacitor connection to ground.
15	PGND	Power ground.
16	BG	Gate driver output for low-side N-Channel power FET.
17	VCCP	Power Input voltage pin.
18	SWN	Inductor driven node of the SMPS, the return for high-side gate driver, and also serve as the lower supply rail of the high-side gate driver of the SMPS.
19	TG	Gate driver output for high-side N-Channel power FET.
20	VBST	Positive supply of high-side gate driver of the SMPS. Connect boost capacitor between this pin and switching node SWN of the SMPS.
21	THPAD	Copper pad on bottom of IC used for heatsinking. This pin should be connected to the ground plane under the IC.

#### **ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Power Supply Voltage to AGND (V <sub>CC</sub> internally connects to LDO5)	V <sub>LDO5</sub>	-0.3, 6.0	V
High-side Gate Drive Supply: BST to SWN High-side FET Gate Drive Voltage: TG to SWN	V <sub>BST</sub> -V <sub>SWN,</sub> V <sub>TG</sub> -V <sub>SWN</sub>	-0.3, 6.0	V
Input / Output Pins (except EN_LDO and OCSET) to AGND	V <sub>IO</sub>	-0.3, 6.0	V
VBAT Input to AGND	$V_{VBAT}$	-0.3, 27	V
EN_LDO Input to AGND OCSET Input to AGND	V <sub>EN_LDO</sub> V <sub>OCSET</sub>	-0.3, 27	V
Switch Node SWN	Vswn	-4 (< 100 ns), -0.3 (dc), 32	V
PGND	$V_{GND}$	-0.3, 0.3	V
Thermal Characteristics QFN20 Plastic Package Thermal Resistance Junction-to-Ambient	$R_{ hetaJA}$	47	°C/W
Operating Junction Temperature Range	TJ	-40 to +150	°C
Operating Ambient Temperature Range	T <sub>A</sub>	-40 to +85	°C
Storage Temperature Range	T <sub>stg</sub>	-55 to +150	°C
Moisture Sensitivity Level	MSL	1	-

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect

device reliability.

1. This device is ESD sensitive. Use standard ESD precautions when handling This device series contains ESD protection and exceeds the following tests: Human Body Model (HBM) ≤ 2.0 kV per JEDEC standard: JESD22–A114 for all pins.

Machine Model (MM) ≤ 200 V per JEDEC standard: JESD22–A115 for all pins.

Latch–up Current Maximum Rating: ≤ 150 mA per JEDEC standard: JESD78.

# **ELECTRICAL CHARACTERISTICS**

 $(V_{BAT} = 12 \text{ V}, LDO5 = V_{CCP} = 5 \text{ V}, T_A = -40 \text{ to } 85^{\circ}\text{C}, \text{ for min/max values unless otherwise noted. Typical values are at } T_A = 25^{\circ}\text{C.})$ 

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
SUPPLY SECTION						
Input Voltage	$V_{BAT}$	Single Supply Configuration, See Figure 2 Ext +5 V and V <sub>IN</sub> Configuration, See Figure 3	6.0 4.5	-	24	V
VBAT Operating Supply Current	I <sub>BAT</sub>	LDO5 & SMPS are Enabled, See Figure 2 TG and BG are 3 nF Capacitor Load V <sub>BAT</sub> = 12 V	-	2	3	mA
		$V_{BAT}$ = LDO5 See Figure 3 TG and BG are 3 nF Capacitor Load $V_{BAT}$ = 5 V	-	-	3	mA
VBAT Shutdown Current	I <sub>BATSD</sub>	V <sub>BAT</sub> = 6 V to 24 V, EN_LDO = 0 V, EN_SW = 0 V	-	10	30	μΑ
UNDERVOLTAGE MONITOR			•	•	•	•
LDO5 UVLO Lower Threshold	VLDO5UV-	Falling Edge	-	4.1	-	V
LDO5 Undervoltage Lockout Hysteresis	VLDO5UVHYS		-	330	-	mV
LINEAR REGULATOR			•	•	•	
LDO5 Input Voltage Range	LDO5_IN	V <sub>BAT</sub> = LDO5 for 5 V Configuration See Figure 3	4.5	5.0	5.5	V
LDO5 Output Voltage	LDO5	$V_{BAT}$ = 6 V to 24 V, EN_LDO > 1.4 V, $I_{LDO5}$ = 0 to 50 mA	4.85	5.0	5.15	V
LDO5 Maximum Output Current	I <sub>LDO5_MAX</sub>	V <sub>BAT</sub> = 6 V to 24 V, EN_LDO > 1.4 V	50	_	_	mA
SMPS CONTROLLERS	_					
FB Feedback Voltage, Control Loop in Regulation	$V_{FB}$	$T_A = 25^{\circ}C$ $T_A = -40 \text{ to } 85^{\circ}C$	0.792 0.788	0.8 0.8	0.808 0.812	V
Operating Frequency	F <sub>SW</sub>		270	300	330	kHz
Ramp Amplitude	$V_{RAMP}$	VOCSET = 12 V (Note 3)	_	1.02	_	V
Ramp Amplitude to VIN Ratio	ΔVRΑΜΡ/ΔVΙΝ	VOCSET = 4.5 V to 24 V (Note 3)	_	83	-	mV/V
Minimum Duty Cycle	D <sub>min</sub>		_	-	0	%
Maximum Duty Cycle	D <sub>max</sub>	VOCSET = 4.5 V to 24 V	90	-	-	%
Voltage Error Amplifier DC Gain	Gain	(Note 3)	_	70	_	dB
Error Amplifier Unity Gain Bandwidth	Ft	COMP to GND = 100 pF, 1.0 $\Omega$ in Series (Note 3)	-	2	-	MHz
Voltage Error Amplifier Slew Rate	SR	(Note 3)	-	3.0	-	V/ìs
OCSET Pin Current Sink	loc	OCSET = 4.0 V	34	40	50	μΑ
OCSET Pin Current Sink Temperature Coefficient	TC <sub>IOC</sub>			3200		ppm/°C
TG Gate Driver Pull-High Resistance	R <sub>H_TG</sub>	V <sub>BST</sub> - V <sub>SWN</sub> = 5 V, V <sub>TG</sub> - V <sub>SWN</sub> = 4 V	-	1.5	4.0	Ω
TG Gate Driver Pull-Low Resistance	R <sub>L_TG</sub>	V <sub>BST</sub> - V <sub>SWN</sub> = 5 V, V <sub>TG</sub> - V <sub>SWN</sub> = 1 V	_	1.5	4.0	Ω
BG Gate Driver Pull-High Resistance	R <sub>H_BG</sub>	V <sub>CCP</sub> = 5 V, V <sub>BG</sub> = 4 V	-	1.5	4.0	Ω
BG Gate Driver Pull-Low Resistance	R <sub>L_BG</sub>	V <sub>CCP</sub> = 5 V, V <sub>BG</sub> = 1 V	_	0.9	3.0	Ω
Soft-start Current	I <sub>ss</sub>	EN_SW = 5.0 V; Vss = 0 V	2.8	4.0	5.2	μΑ
PGDLY Delay Current	I <sub>PG_DLY</sub>	EN_SW = 5.0 V, V <sub>PG_DLY</sub> = 0 V	1.4	2.0	2.6	μΑ
PGDLY Threshold	Vth <sub>PG_DLY</sub>		_	1.25	-	V

<sup>3.</sup> Guaranteed by design, not tested in production.

# **ELECTRICAL CHARACTERISTICS**

 $(V_{BAT} = 12 \text{ V}, LDO5 = V_{CCP} = 5 \text{ V}, T_A = -40 \text{ to } 85^{\circ}\text{C}, \text{ for min/max values unless otherwise noted. Typical values are at } T_A = 25^{\circ}\text{C}.)$ 

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
FAULT DETECTION		•	•		•	
Overvoltage Trip Threshold	OVPth	With Respect to FB Voltage	110	-	120	%
Undervoltage Trip Threshold	UVPth	With Respect to FB Voltage		65	-	%
PGOOD Lower Threshold	VPG-	With Respect to FB Voltage	-20	-	-10	%
PGOOD Pin ON Resistance	PGOOD_R	I_PGOOD = 5.0 mA	-	70	-	Ω
PGOOD Pin Leakage Current	PGOOD_LK		-	-	1.0	μΑ
Thermal Shutdown Trip Point	T <sub>SD</sub>	(Note 3)	-	150	-	°C
Thermal Shutdown Hysteresis	T <sub>SDHYS</sub>	(Note 3)	-	25	-	°C
LOGIC INPUT LEAKAGE		•	•		•	
EN_LDO Threshold High	V <sub>ENLDO_H</sub>	LDO ON	1.4	-	_	V
EN_LDO Threshold Low	V <sub>ENLDO_L</sub>	LDO OFF	-	-	0.5	V
EN_LDO Input Current	I <sub>INLDO_EN1</sub>	EN_LDO = 5.0 V	-	-	1	μΑ
	I <sub>INLDO_EN2</sub>	EN_LDO = 24.0 V	-	-	10	μΑ
EN_SW Threshold High	V <sub>ENSW_H</sub>	SMPS ON	1.4	-	-	V
EN_SW Threshold Low	V <sub>ENSW_L</sub>	SMPS OFF	-	-	0.6	V
EN_SW Input Current	I <sub>INSW_EN</sub>	EN_SW = 5.0 V	-	-	1.0	μΑ
FPWM Threshold High	FPWM_H	Set as Force PWM Mode	1.4	-	-	V
FPWM Threshold Low	FPWM_L	Set as Power Saving Mode	-	_	0.6	V
FPWM Input Current	I <sub>IN_FPWM</sub>	FPWM = 5.0 V	-	_	1.0	μΑ
FOFF Threshold High	FOFF_H	Disable OCP, UVLO & OVP	1.4	_	_	V
FOFF Threshold Low	FOFF_L	OCP, UVLO & OVP are in function	-	_	0.6	V
FOFF Input Current	I <sub>IN_FOFF</sub>	FOFF = 5.0 V (Internal Pull Down by 1 MΩ)	-	5.0	-	μΑ

<sup>3.</sup> Guaranteed by design, not tested in production.

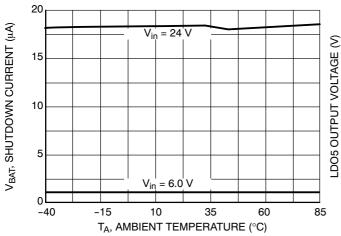


Figure 4. V<sub>BAT</sub> Shutdown Current vs. Ambient Temperature

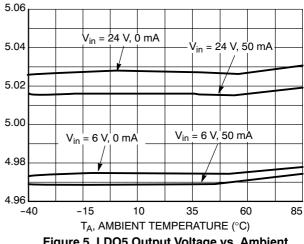


Figure 5. LDO5 Output Voltage vs. Ambient Temperature

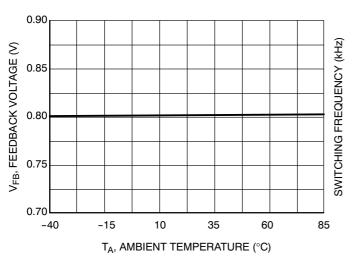


Figure 6. V<sub>FB</sub> Feed Back Voltage vs. Ambient Temperature

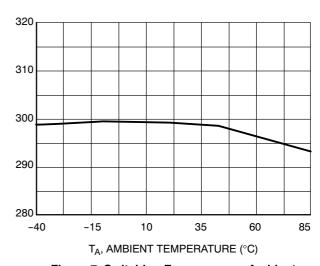


Figure 7. Switching Frequency vs. Ambient Temperature

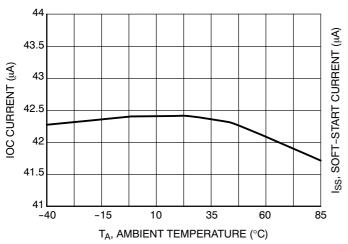


Figure 8. IOC Current vs Ambient Temperature

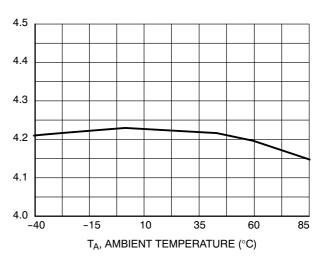
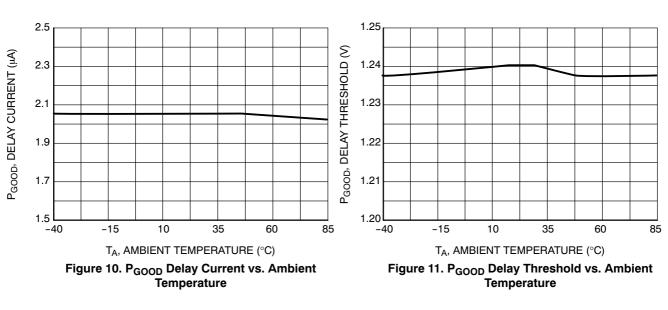


Figure 9. Soft-Start Current vs. Ambient Temperature

#### TYPICAL OPERATING CHARACTERISTICS



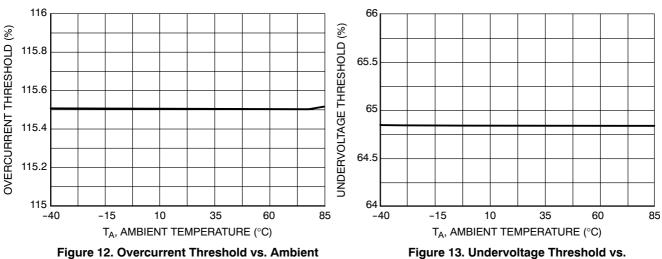


Figure 12. Overcurrent Threshold vs. Ambient Temperature

-14.5

-14.8

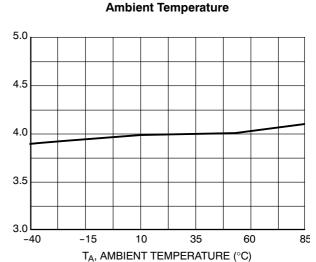
-15

-15.3

-15.5

-40

P<sub>GOOD</sub> LOWER THRESHOLD (%)



T<sub>A</sub>, AMBIENT TEMPERATURE (°C)

Figure 14. P<sub>GOOD</sub> Lower Threshold vs.

Ambient Temperature

10

Figure 15. EN\_LDO Leakage Current vs.
Ambient Temperature

EN\_LDO LEAKAGE @ 24 V (μA)

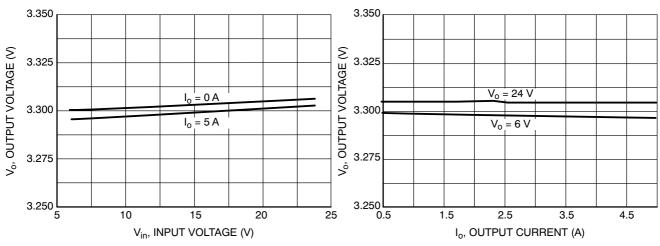


Figure 16. Vo Output Voltage vs. Input Voltage

Figure 17. V<sub>o</sub> Output Voltage vs. Output Current

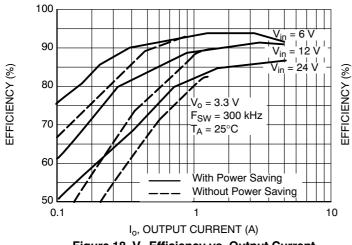


Figure 18. V<sub>o</sub> Efficiency vs. Output Current (Single Supply)

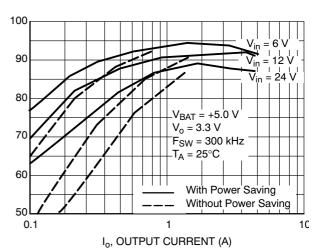


Figure 19. V<sub>o</sub> Efficiency vs. Output Current (Separate Supply)

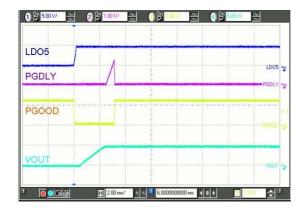


Figure 20. Power Up Sequence



Figure 21. Power Down Sequence

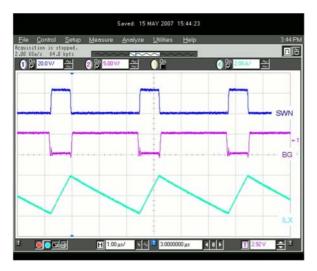


Figure 22. Switcher Operation - CCM Mode

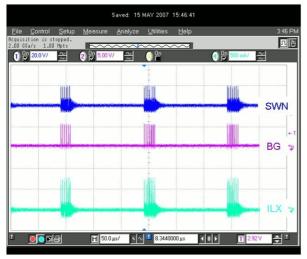


Figure 24. Switcher Operation – Pulse SkippingMode (PSM)

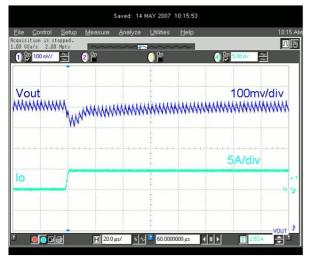


Figure 26. Load Transient - Load Step Up

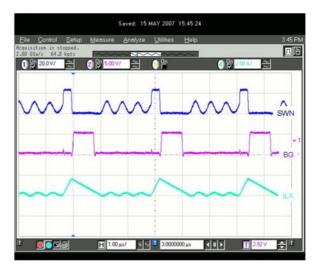


Figure 23. Switcher Operation - DCM Mode

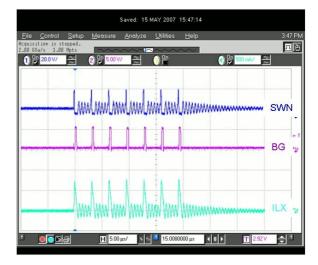


Figure 25. Switcher Operation – PSM Zoom–In

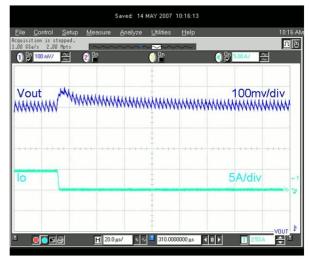


Figure 27. Load Transient - Load Release

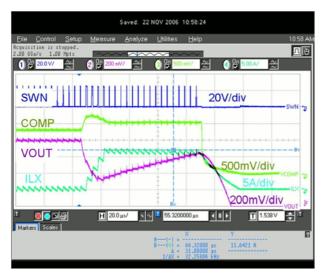


Figure 28. Vout OCP by Short Circuit to Ground

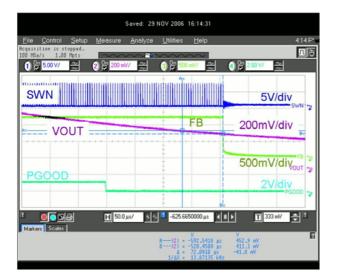


Figure 30. Undervoltage Protection

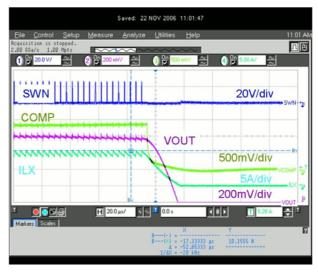


Figure 29. Vout OCP by Steady Iout Increases

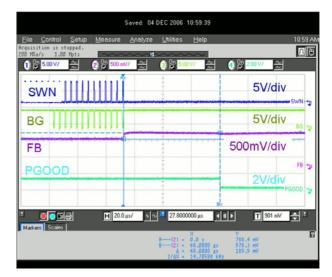


Figure 31. Overvoltage Protection

#### **DETAILED OPERATING DESCRIPTION**

#### General

The NCP1578 synchronous step-down power controller contains a PWM controller and a 5 V/50 mA linear regulator for wide battery/adaptor voltage range applications

The NCP1578 includes power good voltage monitor, soft-start, over current protection, undervoltage protection, overvoltage protection, LDO5 UVLO and thermal shutdown. The NCP1578 allows for improved efficiency at light loads by allowing the synchronous MOSFET to turn off automatically making this device a ideal for battery operated systems. The IC is packaged in QFN20.

#### **Control Logic**

The LDO5 is enabled when EN\_LDO is high. The PWM controller is enabled when EN\_SW is high. The internal  $V_{ref}$  is activated whenever the output of LDO5 rises above the UVLO threshold of 65% of  $V_{FB}$  volts, power-on reset occurs which resets all the protection faults. The device's control logic is powered by LDO5 internally. Once  $V_{ref}$  reaches its regulation voltage, an internal signal will wake up the supply undervoltage monitor which will assert a "GOOD" condition if LDO5 voltage is within certain preset levels.

#### **Linear Regulator**

The 5 V linear regulator can supply total 50 mA current for both internal and external loads. It can be enabled or disabled independently by the control pin EN\_LDO. When EN\_LDO = 1, the UVLO voltage is set as 4.5 V with hystersis 330 mV typical. It is recommended to bypass LDO5 output with 1  $\mu$ F (min) ceramic capacitors.

#### **Switching Controller**

The controller directly drives two external N-Channel power FETs. An external resistor divider sets the nominal output voltage. The control architecture is voltage mode fixed frequency with input voltage feedforward PWM. The part is compensated externally. The switching frequency is fixed at 300 kHz±10%. The SMPS output voltage is divided down via resistor network and fed back to the inverting input of an internal error amplifier through FB pin to close the loop at Vout. This amplifier compares the feedback voltage with an internal V<sub>ref</sub> to generate an error signal for the PWM comparator. This error signal is further compared with a fixed frequency RAMP waveform derived from the internal oscillator to generate a pulse-width-modulated signal. This PWM signal drives the external N-Channel Power FETs via the TG and BG pins. External inductor and capacitor filter the output waveform. The SMPS output voltage ramps up at a pre-defined soft-start rate when the EN SW pin goes HIGH from LOW after V<sub>ref</sub> is ready.

Input voltage feedforward is implemented to the RAMP signal generation to reject the effect of wide input voltage variation. With input voltage feedforward, the amplitude of the RAMP is proportional to the input voltage.

For enhanced efficiency, an active synchronous switch is used to eliminate the conduction loss contributed by the forward voltage of a Schottky diode rectifier. Adaptive nonoverlap timing control of the complementary gate drive output signals is provided to reduce large shoot-through current that degrades efficiency.

When the forced PWM is disabled, the low-side MOSFET is allowed to turn off after the detection of negative inductor current.

#### **Overcurrent Protection of SMPS Controllers**

An external resistor connected between the input voltage and OCSET sets the current limit for the high-side switch. An internal 40 µA current sink (IOC) at OCSET pin establishes a voltage drop across this resistor and develops a voltage at input and is compared to the voltage at SWN pin when the high-side gate drive is high after a fixed period of blanking time (~150 ns) to avoid false current limit triggering. When the voltage at SWN is lower than that at the input for 16 consecutive internal clock cycles, an over current condition occurs. Those 16 consecutive cycles will be operating as cycle by cycle condition in the way such that for each cycle, TG is OFF once the inductor current hits the preset threshold value. The SMPS output will be latched off after those 16 cycles to protect against a short-to-ground condition on SWN or OUT. The IC will be reset once LDO5 or EN\_SW is cycled.

#### **Output Voltages Sensing**

The SMPS output voltage is sensed across the FB and AGND pins. FB should be connected through a feedback resistor divider to the output voltage point of regulation. The AGND should be connected directly through a sense trace to the remote ground sense point which is usually the ground of local bypass capacitor for load.

#### Supply Voltage Under-Voltage Monitor

The IC continuously monitors LDO5 output pin. The IC will shutdown if the voltage is below 4.5 V.

#### **Thermal Shutdown**

The IC will shutdown if the die temperature exceeds 150°C. The IC restarts operation only after the junction temperature drops below 125°C.

#### **Power Good**

The PGOOD is an open-drain output of a comparator which continuously monitors SMPS output voltage. The Power Good time delay can be programmable by connecting an external capacitor. The PGOOD is true (high impedance) when the FB pin is within  $\pm 15\%$  of the preset nominal regulation voltage. The PGOOD is false (pulled low) when FB rises above 15% or falls below 15% the nominal regulation point. PGOOD pin also pulls low when protection fault occurs (OVP, UVP, OTP, and UVLO), or

SMPS is disabled by EN\_SW. Note that the PGOOD pin is valid providing LDO5 is high enough to maintain the internal logic state.

#### **Overvoltage Protection**

When SMPS output voltage is above 115% (typ) the preset nominal regulation voltage for 16 consecutive internal clock cycles, the SMPS output will be latch off and it can be restarted by toggling EN SW or LDO5.

#### **Undervoltage Protection**

When SMPS output falls below 65% (typ) of the nominal regulation voltage for 16 consecutive internal clock cycles, the undervoltage fault is set, the SMPS is latched off.

Cycling EN\_SW or LDO5 can reset the undervoltage fault latch and restart the controller.

#### Soft-Start

The switcher  $V_{OUT}$  soft-start feature is incorporated in the device to prevent surge current from power supply and output voltage overshot during power up. When EN\_SW, LDO5 rises above their respective upper threshold voltages, the external soft start capacitor  $C_{ss}$  is charged by a constant current source  $I_{ss}$ . When the soft-start voltage reaches the  $V_{ref}$  voltage, the soft start process is finished. The soft-start time Tss can be programmed by the soft-start capacitor according to the following equation:  $T_{ss} \approx (0.8 \text{ x } C_{ss}) / I_{ss}$ .

**OPERATION TABLE 1** (Single Supply V<sub>BAT</sub> Configuration)

Ir	Input Condition		Operating Condition		Output Condition
FPWM	EN_LDO	EN_SW	SMPS	LDO5	PGOOD
Х	Low	Х	Off	Off	H-Z
Х	High	Low	Off	On	Low
High	High	High	On (FPWM)	On	H-Z
Low	High	High	On (DCM or Pulse Skipping)	On	H-Z

#### **OPERATION TABLE 2** (External +5 V and V<sub>IN</sub> Configuration (Note 4))

Ir	nput Conditio	ition Operating Condition		Output Condition
FPWM	EN_LDO (Note 5)	EN_SW	SMPS	PGOOD
Х	Low	Low	Off	Low
High	Low	High	On (FPWM)	H-Z
Low	Low	High	On (DCM or pulse skipping)	H-Z

<sup>4.</sup> External +5 V is connecting to V<sub>BAT</sub> and LDO5 pin.

<sup>5.</sup> For this configuration, it is recommended to pull EN LDO to GND at any time.

#### **TIMING DIAGRAMS**

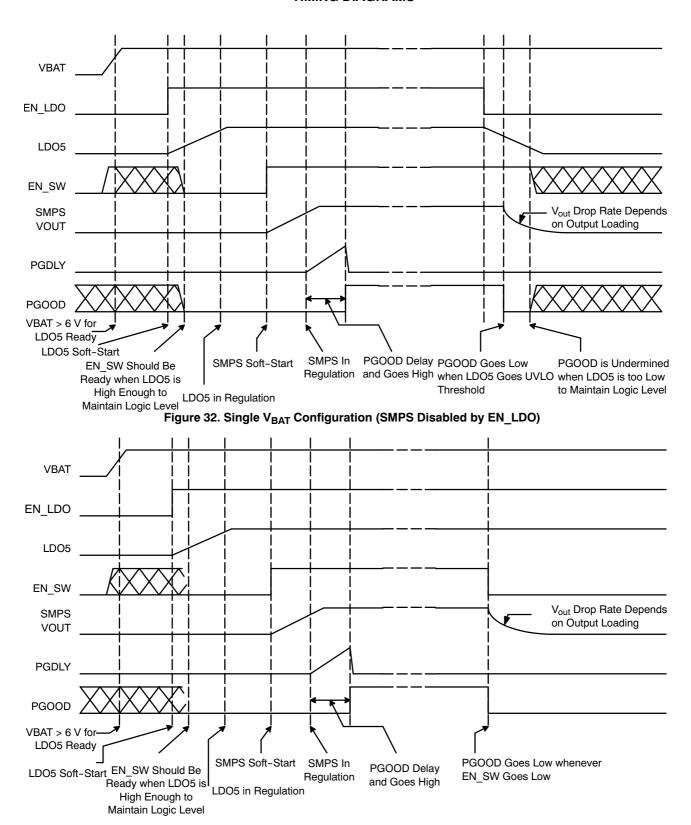


Figure 33. Single V<sub>BAT</sub> Configuration (SMPS Disabled by EN\_SW)

# TIMING DIAGRAMS (Continuous)

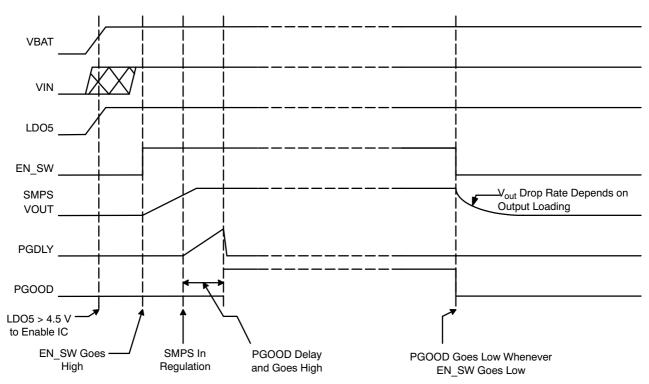


Figure 34. External 5 V (Connect to  $\mathrm{V}_{\mathrm{BAT}}$  and LDO5) and  $\mathrm{V}_{\mathrm{in}}$  Configuration

#### **GENERAL APPLICATION INFORMATION**

#### Introduction

Figure 35 depicts the general control blocks of voltage mode control loop for a synchronous-rectified buck converter. The voltage output V<sub>out</sub> is regulated to a reference level which is basically governed by the following formula

$$V_{out} = \left(1 + \frac{R1}{R2}\right) \times V_{FB}$$
 (eq. 1)

In order to provide proper regulation, the error amplifier is compared with the internal reference voltage and the output of the error amplifier is used to provide pulse-width modulated (PWM) wave.

#### **Loop Compensation**

Since NCP1578 is a voltage mode PWM controller with LC output filter, type III compensation network is recommended to provide the good closed loop bandwidth and phase boot with stability under any circumstances. The purpose of compensation is to obtain a stable close loop system with the highest possible bandwidth. In another word, we need to obtain a "fast and stable" system.

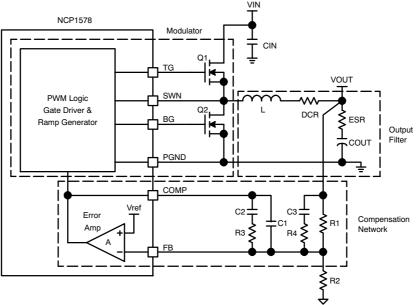


Figure 35. Buck Converter with Modulator, Output Filter and Compensation Network

#### **Equations Involved in Compensation Network**

The following equations are provided as general guidelines for defining the positions of poles and zeros of the compensation network.

#### **Output Filter Break Frequency**

$$F_{LC} = \frac{1}{2\pi \sqrt{L \times C_{out}}}$$
 (LC Double Pole) (eq. 2)

$$F_{ESR} = \frac{1}{2\pi \times ESR \times C_{out}}$$
 (ESR Zero) (eq. 3)

#### **Compensation Network Break Frequency**

$$F_{Z1} = \frac{1}{2\pi \times R3 \times C2} \quad \text{(1st Zero)} \quad \text{(eq. 4)}$$

$$F_{P1} = \frac{1}{2\pi \times R3 \times \left(\frac{C1 \times C2}{C1 + C2}\right)}$$
 (1st Pole) (eq. 5)

$$F_{Z2} = \frac{1}{2\pi \times (R1 + R4) \times C3}$$
 (2nd Zero) (eq. 6)

$$F_{P2} = \frac{1}{2\pi \times R4 \times C3}$$
 (2nd Pole) (eq. 7)

## Guidelines for selecting compensation component

- 1. Select a value of R1 between 2 k $\Omega$  and 5 k $\Omega$
- 2. Target for close loop bandwidth should be less than 50% of switching frequency
- 3. Place 1<sup>st</sup> zero at 50% of filter double pole.
- 4. Place 1st pole at ESR zero
- 5. Place 2<sup>nd</sup> zero at filter double pole
- 6. Place 2<sup>nd</sup> pole at half the switching frequency.

Figure 36 shows an asymptotic plot of the converter gain against frequency. It gives the general trend of how system and its individual components behave. Actually, the Modulator and Filter Gain has a high peak due to the high Q factor of the output filter. The Open Loop Error Amplifier Gain bounds the Compensation Gain. The Converter Gain is constructed on the graph by summing up the Modulator and Filter Gain (in dB) and the Compensation Gain (in dB). The Compensation Gain uses the external impedance network (R1, R4, C3, C1, C2, R3 at Figure 35) to provide a

stable and high bandwidth overall loop. Worst case component variation should be considered when selecting

the components of impedance network such that the control loop phase margin should be greater than 45°.

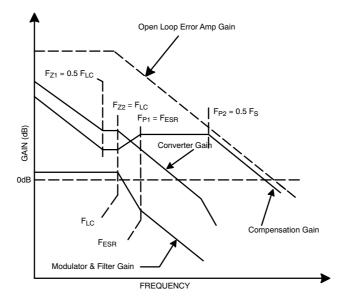


Figure 36. Bode Plot of the Converter Gain

#### **Input Capacitor Selection**

It is used to minimize the input voltage ripple from the power supply source. The input capacitors should be placed as close as possible to the drain of the high-side MOSFET and source of the low-side MOSFET. The PCB trace style should be in form of short and wide ones. The voltage rating and the RMS current rating are the important parameters for the bulk input capacitor. In typical application, the bulk capacitor should be selected such that the voltage and current ratings must above the maximum input voltage and largest RMS current required by system. As a safety guideline, the capacitor voltage rating should be at least 1.5 times greater than the maximum input voltage. And the RMS current rating requirement is approximately half of the DC load current. The required input capacitor RMS ripple current rating may be estimated by the following equation:

$$I_{Cin(RMS)} \ge I_{out} \sqrt{\frac{V_{out}}{V_{in(min)}} - \left(\frac{V_{out}}{V_{in(min)}}\right)^2}$$
 (eq. 8)

Ceramic capacitor is the good choice of the input capacitor for notebook application due to its low ESR and good ripple current rating and high voltage rating. Aluminum electrolytic capacitors are also good choice. They are relatively low cost but they should be used in parallel connection to lower the ESR which is intrinsically high compared with ceramic capacitors.

#### **Output Capacitor Selection**

The output capacitor's ESR will determine the output ripple voltage and the initial voltage drop after a high slew-rate transient. So, only specialized low-ESR

capacitors should be used for switching regulator applications. For steady state ripple, both ESR and capacitance of the output capacitor contribute output ripple voltage. Normally, ESR is the dominant factor for output ripple voltage. The output ripple voltage  $\Delta V_o$  can be estimated by the following equation:

$$\Delta V_{o} = \Delta I_{L} \times ESR + \frac{\Delta I_{L}}{8 \times C_{out} \times F_{S}}$$
 (eq. 9)

and

$$\Delta I_{L} = \frac{(V_{in} - V_{o}) \times V_{o}}{L \times F_{S} \times V_{in}}$$
 (eq. 10)

 $\Delta V_0 = \Delta I_L X ESR$  if  $C_{out}$  is large enough.

Where:

 $\Delta I_L$  = Inductor ripple current

ESR = Effective Series Resistance of the output capacitor

L = Inductance

C<sub>out</sub> = Output capacitance

 $F_S$  = Switching frequency

V<sub>in</sub> = Input Voltage

 $V_0$  = Regulated output voltage

From the above equations, it can be seen that the output ripple voltage can be reduced by either using the inductor with larger inductance or the output capacitor with smaller ESR value. In general rule of thumb, the inductor ripple current is typically 30% of the maximum load current and the ripple voltage is typically 2% of the output voltage.

The output capacitor also plays an important role in response of load step up or release transients. The voltage undershoot  $\Delta V^-$  due to load step up  $\Delta I$  can be estimated by the following equation:

$$\Delta V^{-} = \Delta I \times ESR + \frac{\Delta I}{C_{out}} \times \left[ \frac{I - \frac{V_o}{V_{in}}}{F_S} \right]$$
 (eq. 11)

and the voltage overshoot  $\Delta V^+$  due to load release can be estimated by the following equation:

$$\Delta V^{+} = \sqrt{\frac{L \times \left(I_{o} + \frac{\Delta I_{L}}{2}\right)^{2} + C_{out} \times V_{o}^{2}}{C_{out}}} - V_{OUT}^{\text{(eq. 12)}}$$

Where:

I<sub>O</sub> = Load current step

Other parameters for selection of output capacitor are the voltage rating and ripple current rating. In general, the voltage rating should be at least 1.25 times the output voltage and the RMS ripple current rating should be greater then the inductor ripple current.

#### **Output Inductor Selection**

Basically, a physical inductor can be simply modeled as two components: an ideal inductance L and an ideal resistor DCR. The value of L determines the output ripple voltage, inductor ripple current and performance of load transients. And DCR contributes the system loss. Hence, the higher the DCR, the lower the efficiency of the system will be.

In general, the typical inductor ripple current is 30% of the maximum load current. So based on this criteria, by simple rearrangement of Equation 10, the required inductance can be estimated as follow:-

$$L \ge \frac{\left(V_{in} - V_{o}\right) \times V_{o}}{0.3 \times I_{O(max)} \times V_{in} \times F_{S}}$$
 (eq. 13)

Where:

 $I_{O(max)}$  = Maximum load current

In addition, The DC current rating of the inductor should be about 1.2 times of the peak inductor current at maximum output load current and in order to achieve the good system efficiency, DCR should be minimized. In general, inductor with about 2 m $\Omega$  to 3 m $\Omega$  per  $\mu$ H should be used. In some cases, larger inductor value can be selected to achieve higher efficiency as long as it still meets the required voltage overshoot at load release and inductor DC current rating.

#### **MOSFET Selection**

For selection of MOSFET, gate drive voltage  $(V_{GS})$ , ON-Resistance  $(R_{DSON})$ , gate input capacitance  $(C_{GS})$  and gate charges  $(Q_G, Q_{GD})$  and  $(Q_{GS})$  are the key parameters to be considered.

For ON-resistance, in consideration of efficiency and power dissipation, it should be the lower the better. In general, for the buck converter, the R<sub>DSON</sub> of low side MOSFET is usually lower than that of high side MOSFET.

It is because the switching on time of lower side MOSFET is longer than that of high side MOSFET especially at the high  $V_{in}$  and low  $V_{o}$  case. For practical application, high side MOSFET and low side MOSFET with RDSON about 7.0 m $\Omega$  and 5.0 m $\Omega$  respectively can achieve good efficiency.

In order to have better immunity to low side MOSFET false switching on due to high dV/dt switching slew rate of the high side MOSFET, the low side MOSFET should be selected such that the ratio  $Q_{GD}/Q_{GS}$  should be low enough.

#### **Overcurrent Protection Component Selection**

The overcurrent protection will trip when a peak inductor current hit the I<sub>LIM</sub> which is determined by the equation:-

IsubsLim = 
$$\frac{R_{OC} \times I_{OC}}{R_{DS(on)\_HS}}$$
 (eq. 14)

Where:

$$\begin{split} R_{OC} &= Resistor \ across \ OCSET \ pin \ and \ V_{in} \\ I_{OC} &= Constant \ current \ flowing \ into \ the \ OCSET \ pin \\ R_{DS(on)\_HS} &= \ On \ resistance \ of \ the \ high \ side \ MOSFET \end{split}$$

Since  $I_{OC}$  is varying with device to device and high side MOSFET's  $R_{DS(on)}$  varies with temperature, so in order to prevent from mis-triggering the over current protection in normal operating condition,  $R_{OC}$  should be determined based on the following corner conditions:-

- 1. The minimum I<sub>OC</sub> value from the electrical table.
- 2. The maximum high side MOSFET's R<sub>DS(on)</sub> used at the highest junction temperature.
- 3. Estimate  $I_{LIM}$  such that  $I_{LIM} > I_{o\_max} + \Delta I_L/2$  where  $I_{o\_max} = Maximum$  output current rating,  $\Delta I_L = Inductor$  ripple current.

In addition, a decoupling capacitor Coc should be added in parallel with  $R_{OC}$  for noise filtering purpose.

# **PCB Layout Guidelines**

The following items should be considered when preparing PCB layout:

- 1. All high current traces should be kept as short and wide as possible to reduce power loss. For example the input voltage terminal to the drain of high-side MOSFET, trace from inductor to the output terminal, etc. Power handling and heat sinking capability of power traces can be improved by multiple trace routing at different layer and join them together with multiple vias.
- Power components which include the input capacitor, MOSFETs, inductor and output capacitor must be placed close together to minimize the current loop.
- 3. The thermal pad of the QFN20 package should be connected to the ground planes for providing good heat dissipation. It is recommended to use PCB with 1 oz or 2 oz copper foil. The thermal pad can

- be connected to either PGND or AGND but not on the both.
- 4. The ground terminals of input and output capacitors, and the low-side MOSFET's source pin should be connected to PGND ground plane through (if necessary) multiple vias.
- Noise sensitive traces such as traces of FB, COMP and OCSET should be placed in order to prevent from interference of high voltage switching signal traces like SWN, VBST, TG and BG.
- 6. The feedback resistor divider should be placed as close as possible to FB pin. The output voltage sensing signal should be come up from the separated noise free signal trace.
- 7. To minimize the effect of parasitic impedance, traces between gate drivers to MOSFET's gates should be as shortest as possible.

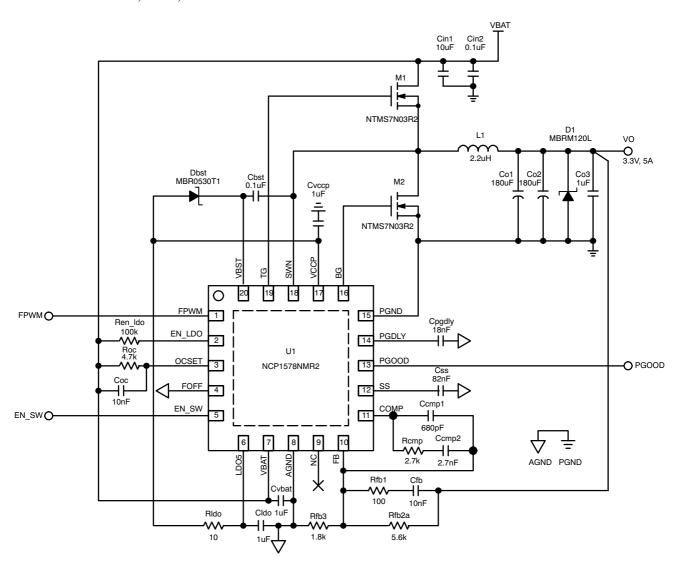
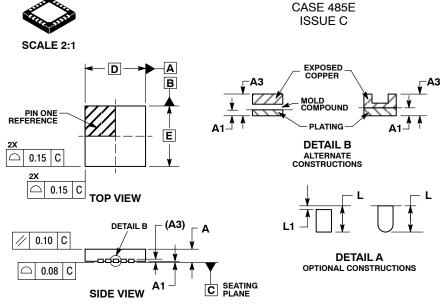


Figure 37. Typical Application Schematic Diagram

# BILL OF MATERIAL (BOM) FOR THE TYPICAL APPLICATION SCHEMATIC

Item	Qty	Designator	Part Description	Vendor
1	1	U1	NCP1578 Buck Controller	ON Semicondutor
2	2	M1, M2	NTMS7N03R2 MOSFET N-Ch 7A, 30V, 23mΩ @ 4.5V	ON Semicondutor
3	1	D1	MBRM120L Schottky Diode 1A, 20V, POWERMITE	ON Semicondutor
4	1	Dbst	MBR0530T1 Schottky Diode 0.5A, V <sub>F</sub> =0.375V @ 0.1A, SOD-123	ON Semicondutor
5	1	L1	FDA1055-2R2M 2.2uH, 4.8mΩ max	токо
6	2	Co1, Co2	SP-CAP, 180uF, 6.3V, ESR=10m $\Omega$ SIZE-D	Panasonic
7	1	Cin1	Ceramic Capacitor 10uF/25V, 2512	
8	4	Co3, Cvbat, Cldo, Cvccp	Ceramic Capacitor 1uF/10V, 0805	
9	2	Cin2, Cbst	Ceramic Capacitor 0.1uF/25V, 0603	
10	1	Cpgdly	Ceramic Capacitor 18nF/50V, 0603	
11	1	Css	Ceramic Capacitor 82nF/50V, 0603	
12	1	Ccmp1	Ceramic Capacitor 680pF/50V, 0603	
13	1	Ccmp2	Ceramic Capacitor 2.7nF/50V, 0603	
14	2	Cfb, Coc	Ceramic Capacitor 10nF/50V, 0603	
15	1	Rcmp	Resistor 2.7kΩ, 0603	
16	1	Rfb1	Resistor 100Ω, 0603	
17	1	Rfb2a	Resistor 5.6kΩ, 0603	
18	1	Rfb3	Resistor 1.8kΩ, 0603	
19	1	Rldo	Resistor 10Ω, 0603	
20	1	Ren_ldo	Resistor 100kΩ, 0603	
21	1	Roc	Resistor 4.7kΩ, 0603	

**DATE 13 FEB 2018** 



QFN20, 4x4, 0.5P

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- FROM THE TERMINAL TIP.

  4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS		
DIM	MIN MAX		
Α	0.80	1.00	
A1	0.05		
A3	0.20	REF	
b	0.20	0.30	
D	4.00 BSC		
D2	2.60 2.90		
E	4.00	BSC	
E2	2.60	2.90	
е	0.50	BSC	
K	0.20 REF		
L	0.35	0.45	
L1	0.00	0.15	

#### **GENERIC MARKING DIAGRAM\***



XXXXXX= Specific Device Code

= Assembly Location

= Wafer Lot LL = Year Υ

= Work Week

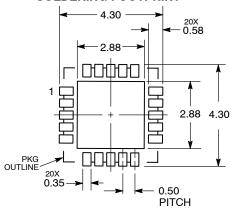
= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

# 0.10 C A B DETAIL A 0.10 C A B $\oplus$ F2 20X b 0.10 | C | A | B Ф 0.05 C NOTE 3 **BOTTOM VIEW**

#### **SOLDERING FOOTPRINT\***



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